Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/768,851	SANPEI, KENICHI
Examiner	Art Unit
Justin P. Misleh	2612

	SEVD	CHED	
	SEAR	CHED	
Class	Subclass	Date	Examiner
348	311	11/12/2005	JPM
348	312	11/12/05	JPM

Subclass		
	Date	Examiner
		-
	Subclass	Subclass Date

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR